

<b>Notice of References Cited</b>	Application/Control No. 10/001,709	Applicant(s)/Patent Under Reexamination SAIKI ET AL.	
	Examiner A. Sefer	Art Unit 2826	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-6,498,633	12-2002	Ozeki et al.	349/96
	C	US-			
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	G	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	N	JP 6-59123	03-1994	Japan	Yoshimi et al.	
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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